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Application/Control No.	Applicant(s)/Patent under Reexamination	
10/042,165	LIN ET AL.	
Examiner	Art Unit	
Mark A. Mais	2616	

	SEARCHED		
Class	Subclass	Date	Examiner
370	230 235 242	9/18/2006	МАМ
	245 252		
	351-355		
	357 392		
	400 401		
	404 419		
	420 437		
	447 448		
	450 451		
	453 455		
	462 464		
	465 508		1
	516 517		
	519 528	3/18/2007	МАМ

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
370	447 450 528	3/18/2007	MAM
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SEARCH NOT (INCLUDING SEARCH) _
·	DATE	EXMR
See Attached electronic Search	9/18/2006	MAM
Non-Patent Literature Search	- 9/18/2006	MAM
See Inventorship Search	3/18/2007	MAM
See Attached Electronic Search [updated]	3/18/2007	МАМ
See Attached Interference Search	3/18/2007	MAM